## Search Notes



Appl	icat	ion/	Con	trol	No.

Applicant(s)/Patent Under Reexamination 10541906 FINCH ET AL.

Examiner

Art Unit

Barker, Matthew

3662

## SEARCHED

02.11.01.125					
Class	Subclass	Date	Examiner		
342	157.2,194,	12/21/2006	Hien Le		
342	163,159-164	8/9/2007	Hien Ly		
342	160	6/12/2008	MMB		
	updated	1/2/2009	MMB		

## CEARCH NOTES

SEARCH NOTES					
Search Notes	Date	Examiner			
Inventor's name search	12/20/2006	Hien Ly			
NPL search	12/20/2006	Hien Ly			
Plus search	12/20/2006	Hien Ly			
Text search	12/20/2006	Hien ly			
NPL search (update)	8/8/2007	Hien ly			
Text search (update)	8/8/2007	Hien Ly			
342/104, 105, 109, 115, 194, 195, 161, 162, 164 - test search, see printoutx	6/12/2008	MMB			
EAST text search - see printout	6/13/2008	MMB			
Updated text search - see printout	1/2/2009	MMB			

## INTERFERENCE SEARCH

Class	Subclass	Date	Examiner

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